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# AO4854

# 30V Dual N-channel MOSFET

### **General Description**

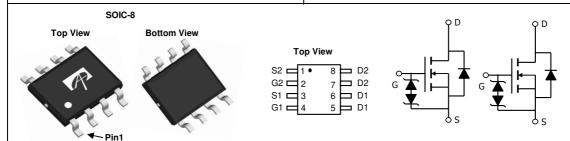
The AO4854 uses advanced trench technology to provide excellent  $R_{\rm DS(ON)}$  and low gate charge. The two MOSFETs make a compact and efficient switch and synchronous rectifier combination for use in DC-DC converters.

# **Product Summary**

 $\begin{array}{lll} V_{DS} & 30V \\ I_D \ (at \ V_{GS}{=}10V) & 8A \\ \\ R_{DS(ON)} \ (at \ V_{GS}{=}10V) & <19 m\Omega \\ \\ R_{DS(ON)} \ (at \ V_{GS} = 4.5V) & <23 m\Omega \\ \\ R_{DS(ON)} \ (at \ V_{GS} = 4V) & <26 m\Omega \end{array}$ 

ESD Protected 100% UIS Tested 100% R<sub>g</sub> Tested





Absolute Maximum Ratings T <sub>A</sub> =25°C unless Parameter		Symbol	Maximum	Units	
Drain-Source Voltage		V <sub>DS</sub>	30	V	
Gate-Source Voltage		V <sub>GS</sub>	±20	V	
Continuous Drain	T <sub>A</sub> =25℃		8		
Current	T <sub>A</sub> =70℃	'D	6.5	A	
Pulsed Drain Current <sup>C</sup>		I <sub>DM</sub>	48		
Avalanche Current <sup>C</sup>		I <sub>AS</sub> , I <sub>AR</sub>	19	A	
Avalanche energy L=0.1mH <sup>C</sup>		E <sub>AS</sub> , E <sub>AR</sub>	18	mJ	
	T <sub>A</sub> =25℃	P <sub>D</sub>	2	W	
Power Dissipation <sup>B</sup>	T <sub>A</sub> =70℃	l D	1.3	vv	
Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	°C	

Thermal Characteristics								
Parameter	Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient A	t ≤ 10s	$R_{\theta JA}$	48	62.5	€/M			
Maximum Junction-to-Ambient AD	Steady-State	п <sub>θ</sub> ЈА	74	90	€/M			
Maximum Junction-to-Lead Steady-St		$R_{\theta JL}$	32	40	€/M			



#### Electrical Characteristics (T<sub>J</sub>=25℃ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units		
STATIC F	PARAMETERS							
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	30			V		
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =30V, V <sub>GS</sub> =0V			1	μΑ		
		T <sub>J</sub> =55℃			5			
$I_{GSS}$	Gate-Body leakage current	$V_{DS}$ =0V, $V_{GS}$ = ±20V			10	μΑ		
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS} I_{D}=250\mu A$	1.2	1.8	2.4	V		
$I_{D(ON)}$	On state drain current	$V_{GS}=10V$ , $V_{DS}=5V$	30			Α		
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	$V_{GS}$ =10V, $I_D$ =8A		15.5	19	19 mΩ		
		T <sub>J</sub> =125℃		21	25	11122		
		$V_{GS}$ =4.5V, $I_D$ =4A		18.5	23	$m\Omega$		
		$V_{GS}$ =4V, $I_D$ =4A		20.5	26	$m\Omega$		
g <sub>FS</sub>	Forward Transconductance	$V_{DS}=5V$ , $I_{D}=8A$		30		S		
$V_{SD}$	Diode Forward Voltage	$I_S=1A, V_{GS}=0V$		0.75	1	V		
Is	Maximum Body-Diode Continuous Current				2.5	Α		
DYNAMIC	PARAMETERS			-				
C <sub>iss</sub>	Input Capacitance		600	740	888	pF		
C <sub>oss</sub>	Output Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =15V, f=1MHz	77	110	145	pF		
$C_{rss}$	Reverse Transfer Capacitance	7	50	82	115	pF		
$R_q$	Gate resistance	$V_{GS}$ =0V, $V_{DS}$ =0V, f=1MHz	0.5	1.1	1.7	Ω		
SWITCHI	NG PARAMETERS		•		-			
Q <sub>q</sub> (10V)	Total Gate Charge		12	15	18	nC		
Q <sub>g</sub> (4.5V)	Total Gate Charge	V 10V V 15V L 0A	6	7.5	9	nC		
$Q_{gs}$	Gate Source Charge	$V_{GS}=10V, V_{DS}=15V, I_{D}=8A$	2	2.5	3	nC		
$Q_{gd}$	Gate Drain Charge	7	2	3	5	nC		
t <sub>D(on)</sub>	Turn-On DelayTime			5		ns		
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}=10V, V_{DS}=15V, R_{L}=1.8\Omega,$		3.5		ns		
t <sub>D(off)</sub>	Turn-Off DelayTime	$R_{GEN}=3\Omega$		19		ns		
t <sub>f</sub>	Turn-Off Fall Time	7		3.5		ns		
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =8A, dI/dt=500A/μs	6	8	10	ns		
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge	l <sub>F</sub> =8A, dl/dt=500A/μs	14	18	22	nC		
A The value of P is manufacted with the device mounted on tin <sup>2</sup> EP 4 heard with 2c7 Copper in a ctill air programment with T = 25°C. The								

A. The value of  $R_{\theta JA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A$  =25°C. The value in any given application depends on the user's specific board design.

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B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}$ =150°C, using  $\leq$  10s junction-to-ambient thermal resistance.

C. Repetitive rating, pulse width limited by junction temperature  $T_{J(MAX)}=150$ °C. Ratings are based on low frequency and duty cycles to keep initial  $T_J=25$ °C.

D. The  $R_{\theta JA}$  is the sum of the thermal impedence from junction to lead  $R_{\theta JL}$  and lead to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-ambient thermal impedence which is measured with the device mounted on  $1\text{in}^2$  FR-4 board with 2oz. Copper, assuming a maximum junction temperature of  $T_{J(MAX)}=150$ °C. The SOA curve provides a single pulse ratin g.



#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

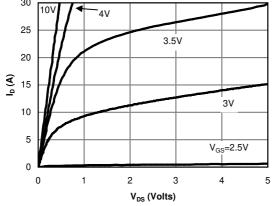


Fig 1: On-Region Characteristics (Note E)

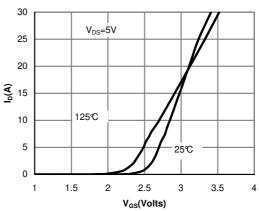


Figure 2: Transfer Characteristics (Note E)

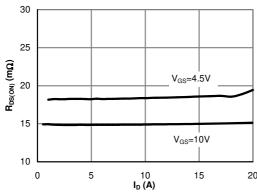


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

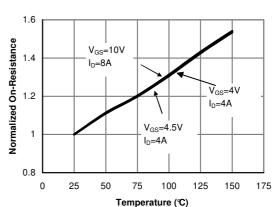


Figure 4: On-Resistance vs. Junction Temperature (Note E)

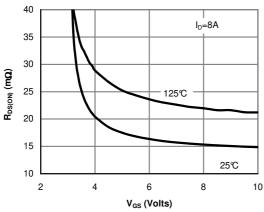


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

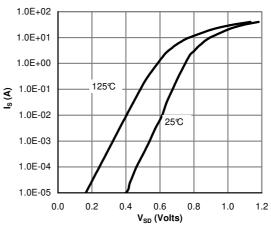


Figure 6: Body-Diode Characteristics (Note E)



#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

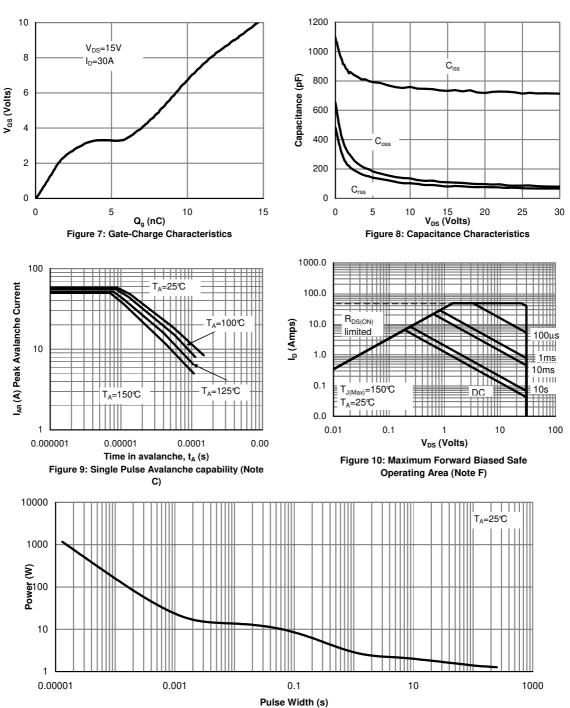


Figure 11: Single Pulse Power Rating Junction-to-Ambient (Note F)



#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

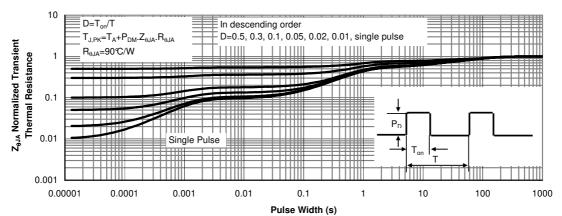
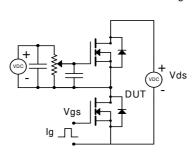
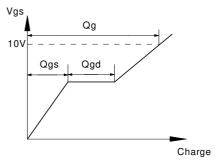


Figure 12: Normalized Maximum Transient Thermal Impedance (Note F)

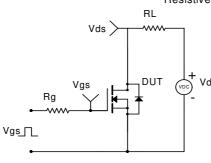


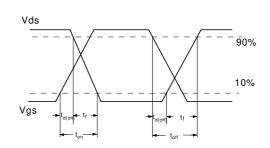
#### Gate Charge Test Circuit & Waveform



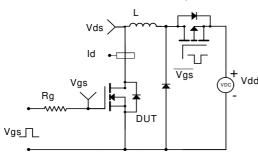


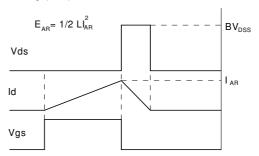
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

